

IN THE UNITED STATES PATENT AND TRADEMARK OFFICE

#28
Am L/E
J. M.
1-150Y

In re Application of Applicants:

Date: October 23, 2003

Beaman et al.

Group Art Unit: 2829

Serial No.: 09/251,988

Examiner: J. M. Hollington

Filed: February 17, 1999

Docket No.: YO999-088

For: STRUCTURAL DESIGN AND PROCESSES TO CONTROL PROBE
POSITION ACCURACY IN A WAFER TEST PROBE ASSEMBLY

Commissioner for Patents

P.O. Box 1450

Alexandria, VA 22313-1450

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AMENDMENT

OCT 23 2003

PETITIONS OFFICE

In response to Office Action dated July 10, 2003, please consider the following:

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OCT 29 2003

OFFICE OF PETITIONS